

ISO IEC 17025 Accredited Accreditation No.: IAS/208



Test report: 1759

02-14-2011

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TI-0893-I60529

LOF-510-02

# TEST REPORT

Project No.: TI-0893-160529

**Test Report for:** Compact Panel

**Manufactured by:** Tabesh Tablo Shargh Co.(T.T.SH)

Tested according to: IEC 60529

Karaj, 02-14-2011

No. of pages

Issue date

6

02-14-2011

**Prepared:** Test & Inspection Engineer

M. Mirfallah

- Un fallah

Verified: Test & Inspection Manager
S. M. Dezfulian

Approved: Engineering Deputy of Test and Inspection

(Representative of Amirkabir University of Technology)

Prof. B. Vahidi

This test report does not include an assessment of the manufacturer's production. Conformity of the production with tested sample is not the responsibility of EPIL.

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## 1. GENERAL INFORMATION

## 1.1 Product Information

Equipment under test

: Compact Panel

Rated Voltage

: 20 kV

Number of Cell

: 3 Cell

S/N

: 9328

Dimension

: 920\* 1670\*(3\*500) mm

Type of Switch

: electromeccanica S.P.A

SF<sub>6</sub> Load Break Switch

:I<sub>r</sub>: 630 A, I<sub>k</sub>/t<sub>k</sub>: 16 KA/S, U<sub>r</sub>: 24 kV, P<sub>r</sub>: 130

kPa, I<sub>ma</sub>: 40 kA

SF6 earthling Switch

: I<sub>k</sub>/t<sub>k</sub>: 16 KA/S, I<sub>ma</sub>: 40 KA

Normative document

: IEC 60529

### 1.2 Client Information

**Applicant** 

: Tabesh Tablo Shargh Co.

Contact person

: Mr. Rajabi

Telephone

: +98 292 3425211

## 1.3 Summary of Tests

IP4X

: Passed

## 1.4 Results of Tests

See pages 4

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## 2 PERFORMANCE AND RESULTS OF TESTS

## 2.1 IP4X, Test for Protection Against Solid Foreign Object

#### 2.1.1 Test data

Location

: E.P.I.L

Date

: 02-12-2011

**Engineer of EPIL** 

: Mrs. Mirfallah

Normative Document

: IEC 60529

#### 2.1.2 Ambient conditions

**Ambient Temperature** 

: 16 °C

Relative Humidity

: 40 %

Atmospheric Pressure

: 86 kPa

#### 2.1.3 Procedure of test

The object probe is pushed against any openings of the enclosure with the force 1±10%N

#### 2.1.4 Results of tests

The protection is satisfactory if diameter of the probe does not pass through any opening. The test was done according to IEC60529 and it passed the test.



PASSED

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## 3 Figure



Figure 1 – EUT Under IP4X

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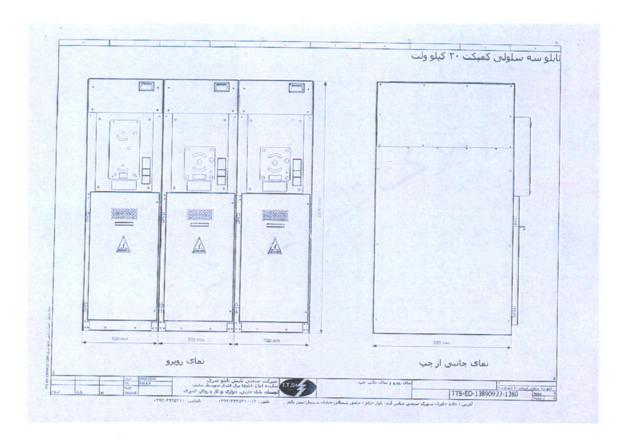
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Annex



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